Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10701698	BLANK ET AL.
Examiner	Art Unit
Bogart, Michael G	3761

SEARCHED				
Class	Subclass	Date	Examiner	
604	411-415, 540, 541, 317, 323, 324, 326, 327, 328, 332, 355, 19, 21, 48, 93.01, 244, 246, 257, 262, 277, 523, 533-535, 537	6/15/2006	MGB	
206	438	6/15/2006	MGB	
222	80, 81, 155, 159, 541.1-541.9	6/15/2006	MGB	
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	search update	5/22/2009	AMM	
	search update	9/29/2009	AMM	
	search update	3/24/2010	AMM	
	search update	9/9/2010	AMM	
	search update	12/15/2010	AMM	
	search update	1/25/2011	AMM	

SEARCH NOTES			
Search Notes	Date	Examiner	
Inventor name search in PALM & eDAN; assignee search; patent family search in esp@cenet; EAST text search.	6/15/2006	MGB	
Update all.	2/17/2007	MGB	
Update all.	7/23/2007	MGB	
Update all.	1/21/2008	MGB	
Update all.	6/4/2008	MGB	
search update	5/22/2009	AMM	
search update	9/29/2009	AMM	
Review ISR for PCT/JP01/11129 performed 22 March 2002, Japanese Patent Office.	9/29/2009	AMM	
search update	3/24/2010	AMM	
search update	9/9/2010	AMM	
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search update	1/25/2011	AMM	

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INTERFERENCE SEARCH			
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206	550	1/25/2011	AMM
428	34.2	1/25/2011	AMM

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